

<b>Notice of References Cited</b>		Application/Control No. 09/276,346	Applicant(s)/Patent Under Reexam Senthil K. Viswanathan et al.	
Examiner Ho		Art Unit 2664	Page 1 of 1	

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	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
A	5,436,886	7/1984 95	McGill	370	219
B	5,398,236	3/1995	Hemmady et al.	370	218
C	5,715,237	2/1998	Akiyoshi	370	228
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<b>A</b>	5,166,926	12/1990 11/1992	Cisneros et al.	370	392
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